

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination VAYANOS ET AL.	
		Examiner Edan Orgad	Art Unit 2684	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0070129	04-2003	Ball et al.	714/748
	B	US-2003/0106009	06-2003	Jarchi et al.	714/755
	C	US-2003/0067899	04-2003	Chen et al.	370/335
	D	US-2002/0105929	08-2002	Chen et al.	370/335
	E	US-			
	F	US-			
	G	US-			
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FOREIGN PATENT DOCUMENTS

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